



Date: May 17, 2004

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(REV. 05/03)

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
EWW-001XXAPPLICATION NO.  
09/496,170

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MAY 21 2004

## INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

APPLICANT:  
Jeffrey Delaney et al.

Technology Center 2600

FILING DATE  
February 1, 2000TC ART UNIT  
2645

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
AA	US 6,631,258	10/7/2003	Chow et al.	455	417	12/13/1999
	US 6,597,688	7/22/2003	Narasimhan et al.	370	353	6/12/1998
	US 6,647,257	11/11/2003	Owensby	455	414.1	12/10/1998
	US 6,630,883	10/7/2003	Amin et al.	340	7.29	12/2/1997
	US 6,498,835	12/24/2002	Skladman et al.	379	88.12	2/29/2000
	US 6,442,592	8/27/2002	Alumbaugh et al.	709	206	12/11/1998
	US 6,442,250	8/27/2002	Troen-Krasnow et al.	379	93.15	8/22/2000

## FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
WO 03/021796 ✓	3/13 2003	PCT			✓
WO 02/087095 ✓	10/31/2002	PCT			✓
WO 02/37393 ✓	5/10/2002	PCT			✓

## OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)


EXAMINER

Allan Hoosain

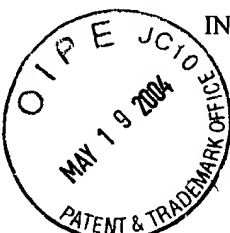
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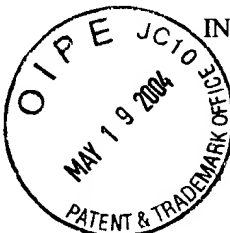
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<b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>				ATTY. DOCKET NO. EWW-001XX		APPLICATION NO. 09/496,170  <div style="text-align: center; font-weight: bold; font-size: 1.2em;">RECEIVED</div> <div style="text-align: center;">MAY 21 2004</div>					
(REV. 05/03) <div style="float: left; width: 150px; text-align: center;">  </div> <div style="clear: both;"></div>				<b>INFORMATION DISCLOSURE CITATION</b> <i>(Use several sheets if necessary)</i>				APPLICANT: Jeffrey Delaney et al.		<b>Technology Center 2600</b>	
				FILING DATE February 1, 2000		TC ART UNIT 2645					
U.S. PATENT DOCUMENTS											
EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE				
AA		US 6,438,584	8/20/2002	Powers	709	206	3/7/2000				
		US 6,363,415	3/26/2002	Finney et al.	709	206	8/11/2000				
		US 6,363,414	3/26/2002	Nicholls et al.	709	206	12/29/1998				
		US 6,072,862	6/6/2000	Srinivasan	379	100.08	7/2/1996				
		US 6,034,970	3/7/2000	Levac et al.	370	466	7/2/1997				
		US 6,021,433	2/1/2000	Payne et al.	709	219	1/24/1997				
		US 5,850,594	12/15/1998	Cannon et al.	455	31.3	8/26/1996				
FOREIGN PATENT DOCUMENTS											
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AA		WO 01/69385 ✓	9/20/2001	PCT			✓				
AA		WO 01/67284 ✓	9/13/2001	PCT			✓				
AA		WO 01/58119 ✓	8/9/2001	PCT			✓				
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A circular black ink stamp from the Office of Intellectual Property (OIP). The text "OIP" is at the top, "JC10" is at the top right, and "PATENT & TRADEMARK OFFICE" is at the bottom. The date "MAY 19 2004" is stamped in the center.

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<b>U.S. DEPARTMENT OF COMMERCE</b> <b>PATENT AND TRADEMARK OFFICE</b>  <div style="display: flex; align-items: center;">  <div> <b>INFORMATION DISCLOSURE CITATION</b>  <i>(Use several sheets if necessary)</i> </div> </div>				ATTY. DOCKET NO. EWW-001XX		APPLICATION NO. 09/496,170  <div style="text-align: center; font-weight: bold; font-size: 1.2em;">           RECEIVED            MAY 21 2004         </div>	
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EXAMINER INITIAL		DOCUMENT NUMBER	PUBLICATION/ ISSUE DATE	NAME	CLASS	SUBCLASS	FILING DATE
AA		US 5,673,256	9/30/1997	Maine	370	271	7/25/1995
		US 5,287,498	2/15/1994	Perelman et al.	395	600	4/2/1991
		US 5,179,660	1/12/1993	Devany et al.	395	200	5/15/1989
		US 2003/0208545	11/6/2003	Eaton et al.	709	206	5/1/2002
		US 2003/0208363	11/6/2003	Thurnher	705	1	9/10/2002
		US 2003/0204556	10/30/2003	Bernard	709	200	1/23/2003
		US 2003/0195937	10/16/2003	Kircher, Jr. et al.	709	207	4/16/2002

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		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES      NO

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)	

EXAMINER <u>Alan Hoosain</u>	DATE CONSIDERED <u>9/9/04</u>
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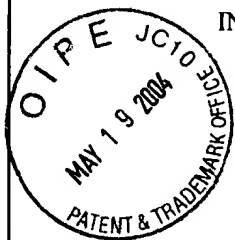
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<div style="font-size: 1.5em; font-weight: bold;">AH</div>	US 2003/0177277	9/18/2003	Dascalu	709	313	3/15/2002	
	US 2003/0163536	8/28/2003	Pettine, Jr.	709	206	8/16/2002	
	US 2003/0161448	8/28/2003	Parolkar et al.	379	88.17	2/27/2002	
	US 2003/0154257	8/14/2003	Hantsch et al.	709	207	2/14/2002	
	US 2003/0126216	7/3/2003	Avila et al.	709	206	9/6/2002	
	US 2003/0110225	6/12/2003	Billadeau	709	206	10/11/2002	
	US 2003/0088465	5/8/2003	Monteverde	705	14	7/24/2000	
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EXAMINER	<div style="font-size: 1.2em; font-family: cursive;">Allan Hossain</div>			DATE CONSIDERED <div style="font-size: 1.2em;">9/9/04</div>			
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AK	US 2003/0088434	5/8/2003	Blechman	705	1	8/1/2002
	US 2002/0177456	11/28/2002	Kimoto et al.	455	466	5/10/2002
	US 2002/0165923	11/7/2002	Prince	709	206	4/17/2001
	US 2002/0161841	10/31/2002	Kinnunen	709	206	4/24/2002
	US 2002/0160794	10/31/2002	Tisserand et al	455	466	12/20/2000
	US 2002/0156896	10/24/2002	Lin et al.	709	227	2/9/2001
	US 2002/0102993	8/1/2002	Hendrey et al.	455	456	7/5/2001

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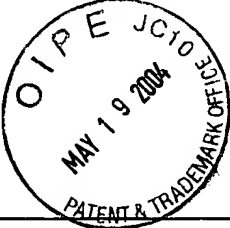
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AH		US 2002/0077130	6/20/2002	Owensby	455	466	12/10/1998
		US 2002/0069116	6/6/2002	Ohashi et al.	705	26	12/1/2000
		US 2002/0065890	5/30/2002	Barron	709	206	11/29/2000
		US 2002/0065889	5/30/2002	Macor	709	206	4/16/1998
		US 2001/0016868	8/23/2001	Nakamura et al.	709	202	5/1/2001
		US 2001/0005859	6/28/2001	Okuyama et al.	709	245	1/30/2001
		US H2079 H	9/2/2003	Menon et al.	370	329	9/29/2000
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